

ID	R _{Ds} (ON)(Typ)	VDSS
13A	0.52Ω	650V

Applications:

- Switch Mode Power Supply(SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)

Features:

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability

\mathbf{r}_{S}

Ordering Information

Part Number	Package	Marking	Packing	Qty.
RS13N65F	T0-220F	RS13N65F	Tube	50 PCS

Absolute Maximun Ratings Tc= 25°C unless otherwise specified

Symbol	Parameter	R\$13N65F	Units
VDSS	Drain-to-Source Voltage	650	V
ID	Continuous Drain Current TC=25 $^{\circ}$ C	13	٨
IDM	Pulsed Drain Current (Note*1)	52	A
PD	Power Dissipation	45	W
VGS	Gate- to- Source Voltage	±30	V
EAS	Single Pulse Avalanche Engergy L = 10mH, VDD = 50V, RG = 25 Ω	387	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	°C
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

* Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

Symbol	Parameter	RS13N65F	Units	Test Conditions
RθJC	Junction-to-Case	1.75	°C/W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^\circ\!\!C$
RθJA	Junction-to- Ambient	62.5		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25° C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	650			V	VGS=0V,ID=250μ Α
IDSS	Drain- to- Source Leakage Current			1	μA	VDS=650V,VGS= 0V
	Gate- to- Source Forward Leakage			100	nA	VGS=30V ,VDS=0 V
IGSS	Gate- to- Source Reverse Leakage			-100		VGS=-30V ,VDS= 0V

ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance(Note*2)		0.52	0.65	Ω	VGS=10V,ID=6.5 A
VGS(TH)	Gate Threshold Voltage	3		4	V	VGS=VDS,ID=25 0μA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		49		nS	VDS=325V ID=13A RG=25Ω
trise	Rise Time		38			
td(OFF)	Turn- OFF Delay Time		245			
tfall	Fall Time		114			



Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		1779			VGS=0V
Coss	Output Capacitance		183		pF	VDS=25V f=1.0MHz
Crss	Reverse Transfer Capacitance		25			
Qg	Total Gate Charge		62			VDS=520V ID=13A VGS=10V
Qgs	Gate- to- Source Charge		9		nC	
Qgd	Gate-to-Drain(" Miller") Charge		32			

Dynamic Characteristics Essentially independent of operating temperature

Source- Drain Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
IS	Continuous Source Current			13	А	Integral pn- diode
ISM	Maximum Pulsed Current			52	А	in MOSFET
VSD	Diode Forward Voltage			1.4	V	IS=6.5A,VGS=0V
trr	Reverse Recovery Time		582		nS	VGS=0V
Qrr	Reverse Recovery Charge		3.5		μC	IS=13A,di/dt=100 A/µs

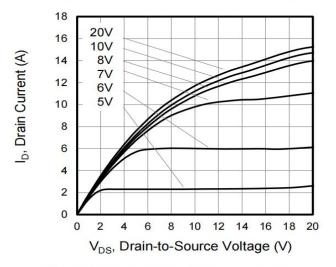
Notes:

- * 1. Repetitive rating, pulse width limited by maximum junction temperature.
- * 2. Pulse Test: Pulse width \leq 300µs, Duty Cycle \leq 1%

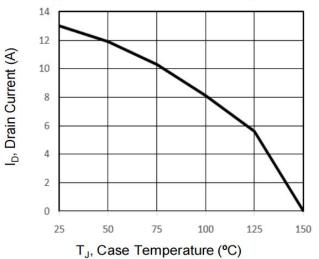


Typical Feature Curve

Figure 1. Output Characteristics (T_J = 25°C)







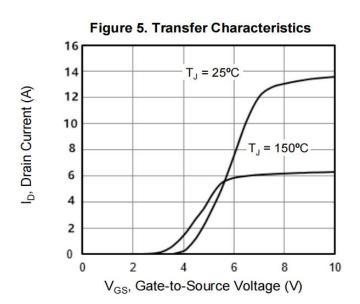


Figure 2. Body Diode Forward Voltage

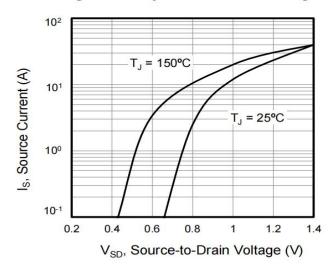


Figure 4. BV_{DSS} Variation vs. Temperature

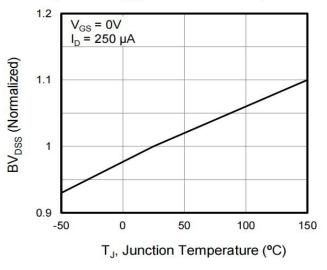
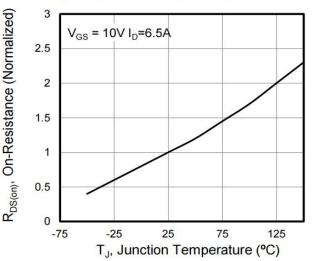
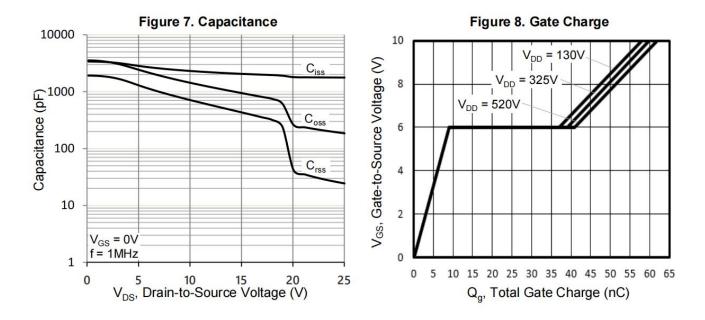


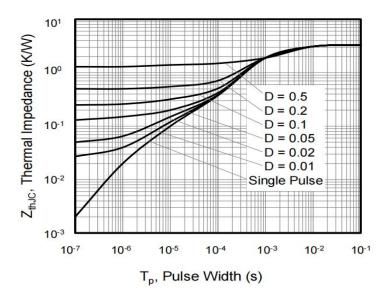
Figure 6. On-Resistance vs. Temperature













Test Circuits and Waveforms

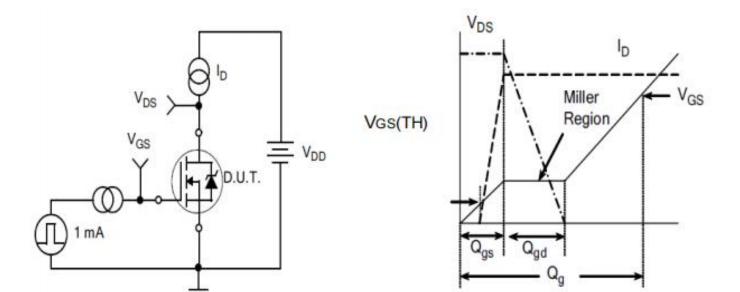
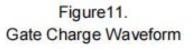


Figure10. Gate Charge Test Circuit



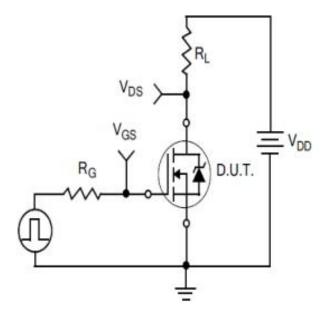


Figure12. Resistive Switching Test Circuit

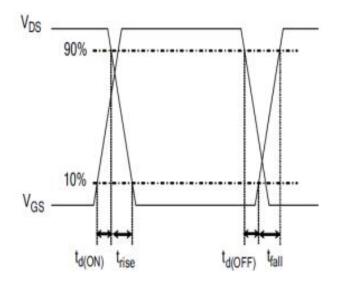
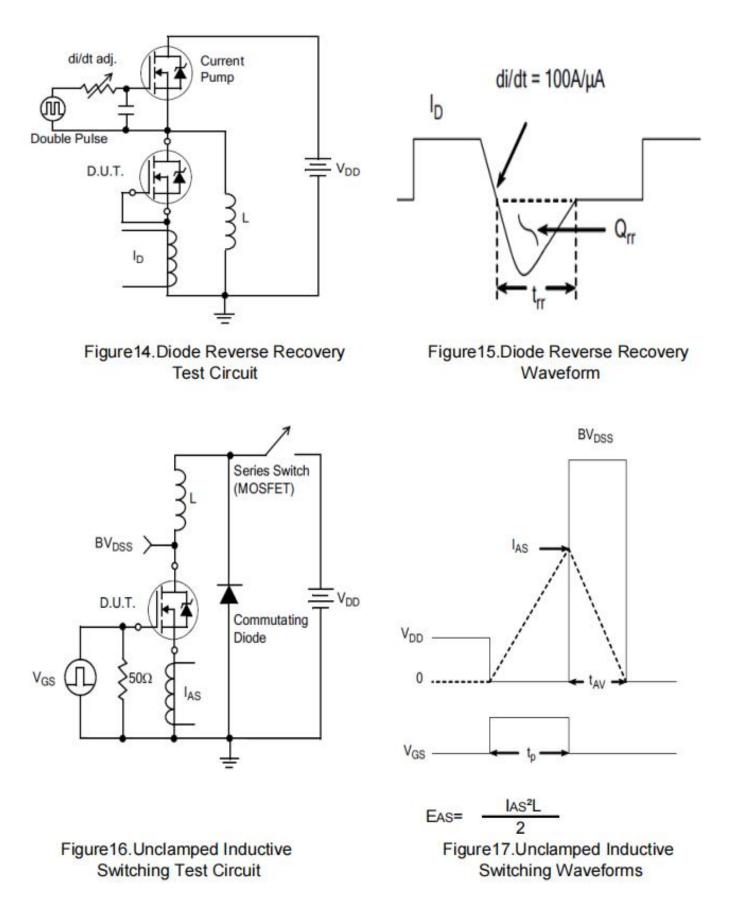


Figure13. Resistive Switching Waveforms

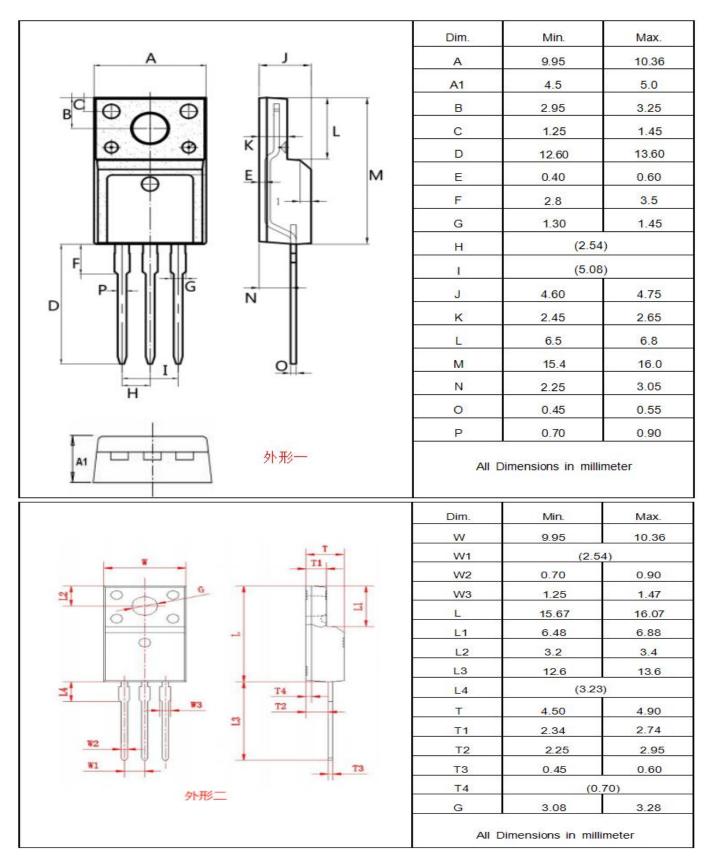


Test Circuits and Waveforms





Package outline drawing(TO-220F Unit: mm)





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